

HIGH-SPEED 3.3V 64K x 16 DUAL-PORT STATIC RAM

70V28L

Features

 True Dual-Ported memory cells which allow simultaneous access of the same memory location

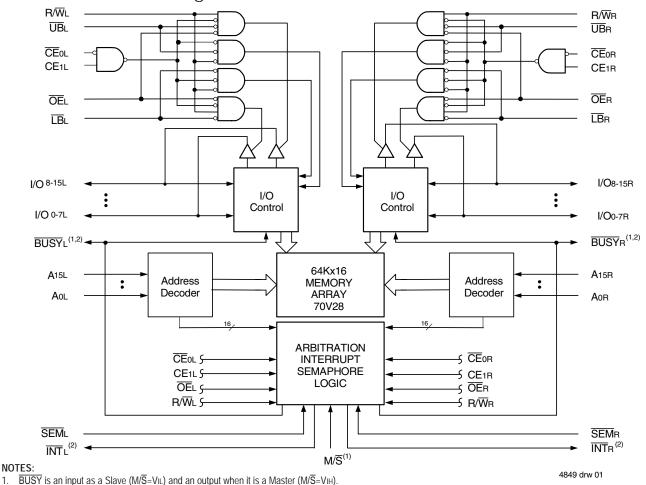
High-speed access

- Commercial: 15/20ns (max.)
- Industrial: 20ns (max.)
- Low-power operation
 - IDT70V28L
 Active: 440mW (typ.)
 - ACTIVE: 440MVV (Typ.)
 - Standby: 660µW (typ.)
- Dual chip enables allow for depth expansion without external logic

Functional Block Diagram

 IDT70V28 easily expands data bus width to 32 bits or more using the Master/Slave select when cascading more than one device

- M/S = VIH for BUSY output flag on Master, M/S = VIL for BUSY input on Slave
- Busy and Interrupt Flags
- On-chip port arbitration logic
- Full on-chip hardware support of semaphore signaling between ports
- Fully asynchronous operation from either port
- Separate upper-byte and lower-byte controls for multiplexed bus and bus matching compatibility
- LVTTL-compatible, single 3.3V (±0.3V) power supply
- Available in a 100-pin TQFP
- Industrial temperature range (-40°C to +85°C) is available for selected speeds
- Green parts available, see ordering information



BUSY is an input as a Slave (M/S=VIL) and an output when it is a Master (M/S BUSY and INT are non-tri-state totem-pole outputs (push-pull).

1

Description

70V28L

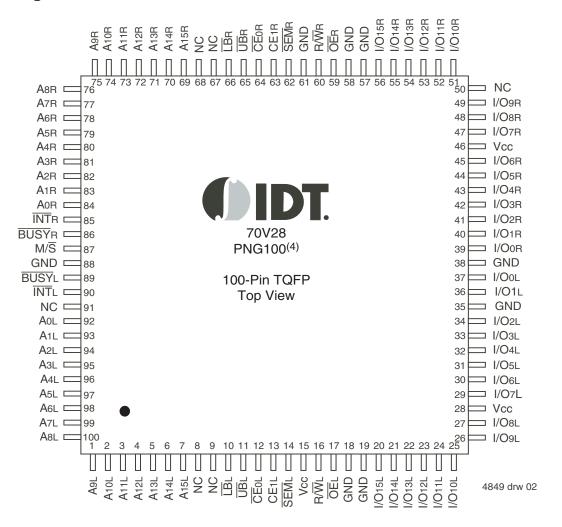
The IDT70V28 is a high-speed 64K x 16 Dual-Port Static RAM. The IDT70V28 is designed to be used as a stand-alone 1024K-bit Dual-Port RAM or as a combination MASTER/SLAVE Dual-Port RAM for 32-bit-or-more word system. Using the IDT MASTER/SLAVE Dual-Port RAM approach in 32-bit or wider memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

This device provides two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down feature controlled by the chip enables (either $\overline{CE}0$ or CE1) permit the on-chip circuitry of each port to enter a very low standby power mode.

Fabricated using CMOS high-performance technology, these devices typically operate on only 440mW of power.

The IDT70V28 is packaged in a 100-pin Thin Quad Flatpack (TQFP).

Pin Configurations^(1,2,3)



- 1. All Vcc pins must be connected to power supply.
- 2. All GND pins must be connected to ground.
- 3. Package body is approximately 14mm x 14mm x 1.4mm.
- 4. This package code is used to reference the package diagram.

Pin Names

Left Port	Right Port	Names
CE0L, CE1L	CEOR, CE1R	Chip Enables
R/WL	R/WR	Read/Write Enable
OEL	ŌĒr	Output Enable
Aol - A15l	Aor - A15r	Address
I/Ool - I/O15l	I/O0r - I/O15r	Data Input/Output
SEM	SEMR	Semaphore Enable
UBL	ŪBR	Upper Byte Select
LB L	LB R	Lower Byte Select
ĪNTL	INT R	Interrupt Flag
BUSYL	BUSYR	Busy Flag
N	NS	Master or Slave Select
V	'cc	Power
G	ND	Ground

4849 tbl 01

Absolute Maximum Ratings⁽¹⁾

Symbol	Rating	Commercial & Industrial	Unit
Vterm ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
Tbias	Temperature Under Bias	-55 to +125	٥C
Tstg	Storage Temperature	-65 to +150	۰C
Ιουτ	DC Output Current	50	mA
NOTEO			4849 tbl 02

NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. VTERM must not exceed Vcc + 0.3V for more than 25% of the cycle time or 10ns maximum, and is limited to \leq 20mA for the period of VTERM \geq Vcc + 0.3V.

Maximum Operating Temperature and Supply Voltage

Grade	Ambient Temperature ⁽¹⁾	GND	Vcc
Commercial	0°C to +70°C	0V	3.3V <u>+</u> 0.3V
Industrial	-40°C to +85°C	0V	3.3V <u>+</u> 0.3V
	-		4849 tbl 03

NOTE:

1. This is the parameter TA. This is the "instant on" case temperature.

Recommended DC Operating Conditions

Symbol	Parameter	Min.	Тур.	Max.	Unit
Vcc	Supply Voltage	3.0	3.3	3.6	V
GND	Ground	0	0	0	V
Vih	Input High Voltage	2.0	_	VCC+0.3 ⁽²⁾	V
Vil	Input Low Voltage	-0.3(1)		0.8	V
					4849 tbl 04

NOTES:

1. VIL \geq -1.5V for pulse width less than 10ns.

2. VTERM must not exceed Vcc + 0.3V.

Capacitance⁽¹⁾ (TA = $+25^{\circ}C$, f = 1.0MHz)

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
Cin	Input Capacitance	VIN = 3dV	9	pF
Соит	Output Capacitance	Vout = 3dV	10	pF
				4849 tbl 05

NOTES:

- 1. This parameter is determined by device characterization but is not production tested.
- 3dV represents the interpolated capacitance when the input and output signals switch from 0V to 3V or from 3V to 0V.

Industrial and Commercial Temperature Ranges

Industrial and Commercial Temperature Ranges

Truth Table I – Chip Enable^(1,2)

CE	CE 0	CE1	Mode
	Vil	Vін	Port Selected (TTL Active)
L	<u><</u> 0.2V	<u>></u> Vcc -0.2V	Port Selected (CMOS Active)
	Vін	Х	Port Deselected (TTL Inactive)
Н	Х	Vil	Port Deselected (TTL Inactive)
	<u>></u> Vcc -0.2V	X ⁽³⁾	Port Deselected (CMOS Inactive)
	X ⁽³⁾	<u><</u> 0.2V	Port Deselected (CMOS Inactive)
	•	•	4849tbl 06

NOTES:

1. Chip Enable references are shown above with the actual \overline{CE}_0 and CE1 levels; \overline{CE} is a reference only.

2. $H' = V_{IH}$ and $L' = V_{IL}$.

3. CMOS standby requires 'X' to be either \leq 0.2V or \geq Vcc-0.2V.

Truth Table II - Non-Contention Read/Write Control

	Inputs ⁽¹⁾					Outputs		
CE ⁽²⁾	R/W	ŌĒ	ŪB	LB	SEM	I/O 8-15	I/O0-7	Mode
Н	Х	Х	Х	Х	Н	High-Z	High-Z	Deselected: Power-Down
Х	Х	Х	Н	Н	Н	High-Z	High-Z	Both Bytes Deselected
L	L	Х	L	Н	Н	DATAIN	High-Z	Write to Upper Byte Only
L	L	Х	Н	L	Н	High-Z	DATAIN	Write to Lower Byte Only
L	L	Х	L	L	Н	DATAIN	DATAIN	Write to Both Bytes
L	Н	L	L	Н	Н	DATAOUT	High-Z	Read Upper Byte Only
L	Н	L	Н	L	Н	High-Z	DATAOUT	Read Lower Byte Only
L	Н	L	L	L	Н	DATAOUT	DATAOUT	Read Both Bytes
Х	Х	Н	Х	Х	Х	High-Z	High-Z	Outputs Disabled

NOTES:

1. AOL — A15L \neq AOR — A15R

2. Refer to Truth Table I - Chip Enable.

Truth Table III – Semaphore Read/Write Control⁽¹⁾

	Inputs ⁽¹⁾					Outputs		
CE ⁽²⁾	R/₩	ŌĒ	ŪB	LB	SEM	I/O 8-15	I/O0-7	Mode
Н	Н	L	Х	Х	L	DATAOUT	DATAOUT	Read Data in Semaphore Flag
Х	Н	L	Η	Н	L	DATAOUT	DATAOUT	Read Data in Semaphore Flag
Н	Ŷ	Х	Х	Х	L	DATAIN	DATAIN	Write I/Oo into Semaphore Flag
Х	Ŷ	Х	Н	Н	L	DATAIN	DATAIN	Write I/Oo into Semaphore Flag
L	Х	Х	L	Х	L			Not Allowed
L	Х	Х	Х	L	L			Not Allowed

NOTES:

1. There are eight semaphore flags written to I/Oo and read from all the I/Os (I/Oo-I/O15). These eight semaphore flags are addressed by Ao-A2.

2. Refer to Truth Table I - Chip Enable.

Industrial and Commercial Temperature Ranges

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (Vcc = 3.3V ± 0.3V)

DC Electrical Characteristics Over the Operating

			70V28L		
Symbol	Parameter	Test Conditions	Min.	Max.	Unit
Lu	Input Leakage Current ⁽¹⁾	Vcc = 3.6V, VN = 0V to Vcc		5	μA
Ilo	Output Leakage Current	$\overline{CE}^{(2)} = VIH$, VOUT = 0V to VCC		5	μA
Vol	Output Low Voltage	IoL = +4mA		0.4	V
Vон	Output High Voltage	IoH = -4mA	2.4	-	V

NOTES:

1. At Vcc < 2.0V, input leakages are undefined.

2. Refer to Truth Table I - Chip Enable.

Temperature and Supply Voltage Range⁽⁵⁾ (Vcc = $3.3V \pm 0.3V$) 70V28I 15 70V28L20 Com'l Only Com'l & Ind Symbol **Test Condition** Version Typ.⁽¹⁾ Typ.⁽¹⁾ Max. Unit Parameter Max. $\frac{\overline{CE}}{\overline{SEM}} = V_{IL}, \text{ Outputs Disabled} \\ \overline{SEM} = V_{IH}$ mΑ lcc Dynamic Operating COM'L L 145 235 135 205 Current $f = fMAX^{(2)}$ (Both Ports Active) IND Т 135 220 ____ Standby Current $\overline{C}\overline{E}L = \overline{C}\overline{E}R = VIH$ COM'L L 40 70 35 mΑ **I**SB1 55 $\frac{OLL - OLK - VIII}{SEMR = SEML = VIII}$ f = fmax⁽²⁾ (Both Ports - TTL Level Inputs) IND L _ 35 65 Standby Current 90 ISB2 $\overline{CE}^{"}A^{"} = VIL \text{ and } \overline{CE}^{"}B^{"} = VIH^{(4)}$ COM'L L 100 155 140 mΑ Active Port Outputs Disabled, f=fMAX⁽²⁾, SEMR = SEML = VIH (One Port - TTL Level İnputs) IND L _____ 90 150 Both Ports \overline{CE}_{L} and $\overline{CE}_{R} \ge Vcc - 0.2V_{c}$ Full Standby Current mΑ ISB3 COM'L L 0.2 3.0 0.2 3.0 <u>VIN > VCC - 0.2V</u> or VIN $\leq 0.2V$, f = 0⁽³⁾ (Both Ports - All CMOS Level Inputs) $\overline{\text{SEMR}} = \overline{\text{SEML}} \ge \text{Vcc} - \overline{0.2}\text{V}$ IND L 0.2 3.0 $\begin{array}{l} \overline{CE^{*}} \mathbb{A}^{*} & \leq 0.2V \text{ and } \overline{CE^{*}} \mathbb{B}^{*} \geq Vcc + 0.2V^{(4)}, \\ \overline{SEM} \mathbb{R} & = \overline{SEM} \mathbb{L} \geq Vcc + 0.2V, \\ \overline{V\mathbb{N}} \geq Vcc + 0.2V \text{ or } V\mathbb{N} \leq 0.2V, \\ \overline{V\mathbb{N}} \geq Vcc + 0.2V \text{ or } V\mathbb{N} \leq 0.2V, \end{array}$ Full Standby Current mA ISB4 COM'L L 95 150 90 135 (One Port - All CMOS Level Inputs) IND L 90 145 Active Port Outputs Disabled, $f = f_{MAX}^{(2)}$

NOTES:

1. Vcc = 3.3V, TA = +25 °C, and are not production tested. Icccc = 90mA (Typ.)

At f = fMax, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/tRc, and using "AC Test Conditions" of input levels of GND to 3V.

3. f = 0 means no address or control lines change.

4. Port "A" may be either left or right port. Port "B" is the opposite from port "A".

5. Refer to Truth Table I - Chip Enable.

4849 tbl 09

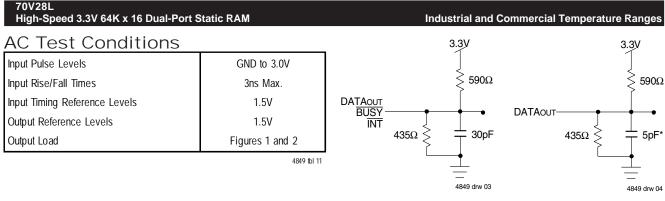
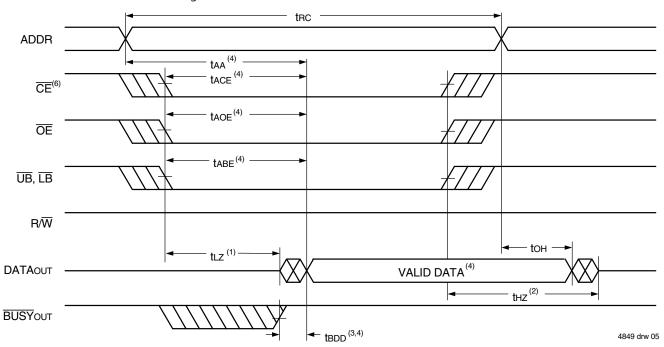


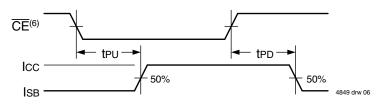
Figure 1. AC Output Load

Figure 2. Output Test Load (for tLz, tHz, twz, tow) * Including scope and jig.

Waveform of Read Cycles⁽⁵⁾



Timing of Power-Up Power-Down



- 1. Timing depends on which signal is asserted last, \overline{OE} , \overline{CE} , \overline{LB} or \overline{UB} .
- 2. Timing depends on which signal is de-asserted first \overline{CE} , \overline{OE} , \overline{LB} or \overline{UB} .
- 3. tbdd delay is required only in cases where the opposite port is completing a write operation to the same address location. For simultaneous read operations BUSY has no relation to valid output data.
- 4. Start of valid data depends on which timing becomes effective last tAOE, tACE, tAA or tBDD.
- 5. SEM = VIH.
- 6. Refer to Truth Table I Chip Enable

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range

			28L15 I Only	70V28L20 Com'l & Ind		
Symbol	Parameter	Min.	Мах.	Min.	Max.	Unit
READ CYCLE						•
trc	Read Cycle Time	15		20		ns
taa	Address Access Time	_	15		20	ns
t ACE	Chip Enable Access Time ⁽³⁾	_	15		20	ns
T ABE	Byte Enable Access Time ⁽³⁾	-	15	_	20	ns
taoe	Output Enable Access Time	_	10	_	12	ns
tон	Output Hold from Address Change	3		3		ns
tLz	Output Low-Z Time ^(1,2)	3		3		ns
tHZ	Output High-Z Time ^(1,2)	_	10		10	ns
tPU	Chip Enable to Power Up Time ⁽²⁾	0		0		ns
tPD	Chip Disable to Power Down Time ⁽²⁾		15		20	ns
tSOP	Semaphore Flag Update Pulse (OE or SEM)	10		10		ns
tsaa	Semaphore Address Access Time		15		20	ns

4849 tbl 12

4849 tbl 13

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage

		70V28L15 Com'l Only		70V28L20 Com'l & Ind		
Symbol	Parameter	Min.	Мах.	Min.	Мах.	Unit
WRITE CYCLE						
twc	Write Cycle Time	15		20	_	ns
tew	Chip Enable to End-of-Write ⁽³⁾	12	_	15		ns
taw	Address Valid to End-of-Write	12	-	15		ns
tas	Address Set-up Time ⁽³⁾	0		0		ns
twp	Write Pulse Width	12	-	15	-	ns
twr	Write Recovery Time	0	-	0		ns
tow	Data Valid to End-of-Write	10		15		ns
tHZ	Output High-Z Time ^(1,2)		10	_	10	ns
tDH	Data Hold Time ⁽⁴⁾	0		0		ns
twz	Write Enable to Output in High-Z ^(1,2)	_	10	_	10	ns
tow	Output Active from End-of-Write ^(1,2,4)	0		0	_	ns
tswrd	SEM Flag Write to Read Time	5	-	5		ns
tsps	SEM Flag Contention Window	5	—	5		ns

NOTES:

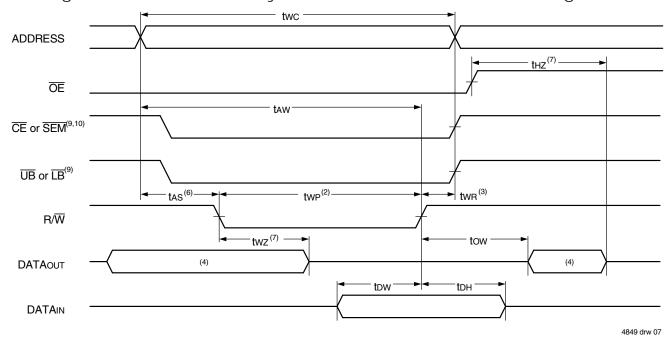
1. Transition is measured 0mV from Low or High-impedance voltage with Output Test Load (Figure 2).

2. This parameter is guaranteed by device characterization, but is not production tested.

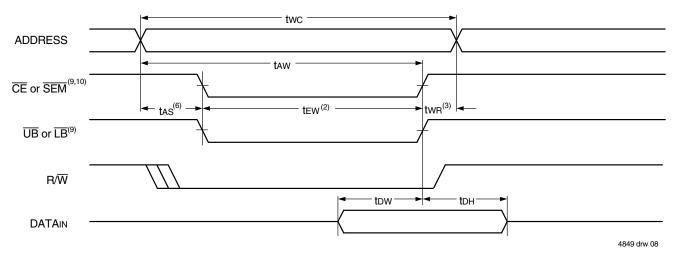
3. To access RAM, \overrightarrow{CE} = VIL and \overrightarrow{SEM} = VIH. To access semaphore, \overrightarrow{CE} = VIH and \overrightarrow{SEM} = VIL. Either condition must be valid for the entire tew time.

^{4.} The specification for tDH must be met by the device supplying write data to the RAM under all operating conditions. Although tDH and tow values will vary over voltage and temperature, the actual tDH will always be smaller than the actual tow.

Timing Waveform of Write Cycle No. 1, R/W Controlled Timing^(1,5,8)

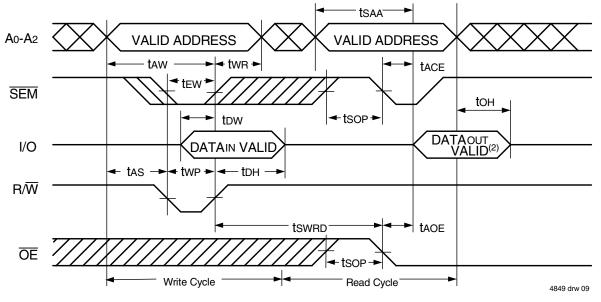


Timing Waveform of Write Cycle No. 2, CE Controlled Timing^(1,5)



- 1. R/\overline{W} or \overline{CE} or \overline{UB} and $\overline{LB} = V \bowtie$ during all address transitions.
- 2. A write occurs during the overlap (tew or twp) of a \overline{CE} = VIL and a R/W = VIL for memory array writing cycle.
- 3. two is measured from the earlier of \overline{CE} or R/\overline{W} (or \overline{SEM} or R/\overline{W}) going HIGH to the end of write cycle.
- 4. During this period, the I/O pins are in the output state and input signals must not be applied.
- 5. If the \overline{CE} or $\overline{SEM} = V_{IL}$ transition occurs simultaneously with or after the $\overline{RW} = V_{IL}$ transition, the outputs remain in the High-impedance state.
- 6. Timing depends on which enable signal is asserted last, \overline{CE} or R/\overline{W} .
- 7. This parameter is guaranteed by device characterization, but is not production tested. Transition is measured 0mV from steady state with the Output Test Load (Figure 2).
- 8. If OE = VIL during R/W controlled write cycle, the write pulse width must be the larger of twp or (twz + tow) to allow the I/O drivers to turn off and data to be placed on the bus for the required tow. If OE = VIH during an R/W controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.
- 9. To access RAM, $\overline{CE} = V_{IL}$ and $\overline{SEM} = V_{IH}$. To access semaphore, $\overline{CE} = V_{IH}$ and $\overline{SEM} = V_{IL}$. tew must be met for either condition.
- 10. Refer to Truth Table I Chip Enable.

Timing Waveform of Semaphore Read after Write Timing, Either Side⁽¹⁾

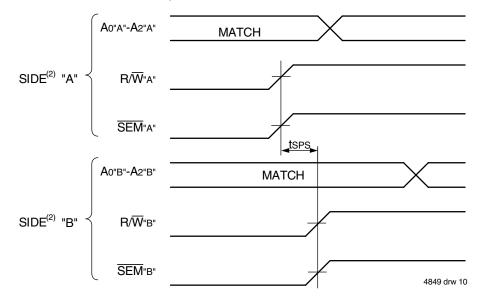


NOTES:

1. $\overline{CE} = V_{H}$ or \overline{UB} and $\overline{LB} = V_{H}$ for the duration of the above timing (both write and read cycle) (Refer to Chip Enable Truth Table).

2. "DATAOUT VALID" represents all I/O's (I/Oo - I/O15) equal to the semaphore value.

Timing Waveform of Semaphore Write Contention^(1,3,4)



- 1. DOR = DOL = VIL, $\overline{CE}L = \overline{CE}R = VIH$ or both \overline{UB} and $\overline{LB} = VIH$ (Refer to Chip Enable Truth Table).
- All timing is the same for left and right ports. Port "A" may be either left or right port. "B" is the opposite from port "A".
 This parameter is measured from RW^{*}A" or SEM^{*}A" going HIGH to RW^{*}B" or SEM^{*}B" going HIGH.
- 4. If types is not satisfied the semaphore will fall positively to one side or the other, but there is no guarantee which side will be granted the semaphore flag.

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range

Cumhal	Deservator		28L15 I Only	70V28L20 Com'l & Ind		11-2
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit
BUSY TIMING	(М/Ѕ=Vн)					
tbaa	BUSY Access Time from Address Match		15		20	ns
tBDA	BUSY Disable Time from Address Not Matched		15		20	ns
tBAC	BUSY Access Time from Chip Enable Low	_	15		20	ns
tBDC	BUSY Access Time from Chip Enable High		15		17	ns
taps	Arbitration Priority Set-up Time ⁽²⁾	5		5		ns
tBDD	BUSY Disable to Valid Data ⁽³⁾		15		17	ns
twн	Write Hold After BUSY ⁽⁵⁾	12		15		ns
BUSY TIMING	(M/S=Vil)					-
twв	BUSY Input to Write ⁽⁴⁾	0		0		ns
twн	Write Hold After BUSY ⁽⁵⁾	12		15		ns
PORT-TO-POR	T DELAY TIMING					
twdd	Write Pulse to Data Delay ⁽¹⁾		30		45	ns
todd	Write Data Valid to Read Data Delay ⁽¹⁾		25		30	ns
						4849 tbl 14

NOTES:

1. Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write with Port-to-Port Read and $\overline{\text{BUSY}}$ (M/ $\overline{\text{S}}$ = VIH)".

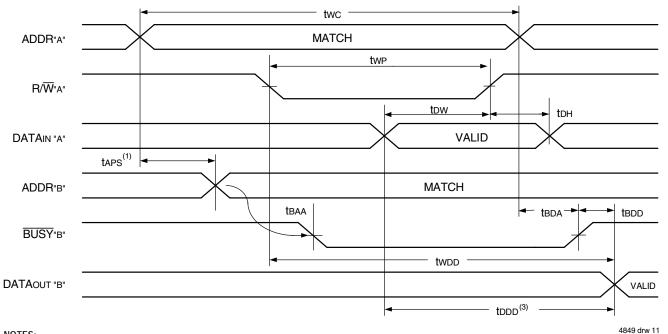
2. To ensure that the earlier of the two ports wins.

3. tBDD is a calculated parameter and is the greater of 0, twDD - twp (actual), or tDDD - tDw (actual).

4. To ensure that the write cycle is inhibited on port "B" during contention on port "A".

5. To ensure that a write cycle is completed on port "B" after contention on port "A".

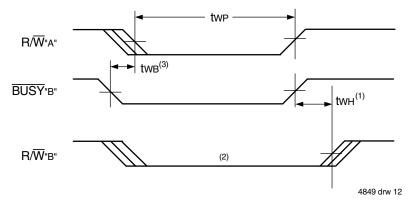
Timing Waveform of Write with Port-to-Port Read and $\overline{\text{BUSY}}$ (M/ $\overline{\text{S}}$ = VIH)^(2,4,5)



NOTES:

- 1. To ensure that the earlier of the two ports wins. taps is ignored for $M/\overline{S} = VIL$ (SLAVE).
- 2. $\overline{CE}_{L} = \overline{CE}_{R} = V_{IL}$, refer to Chip Enable Truth Table.
- 3. $\overline{OE} = V_{IL}$ for the reading port.
- 4. If M/S = VIL (slave), BUSY is an input. Then for this example BUSY "A" = VIH and BUSY "B" input is shown above.
- 5. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

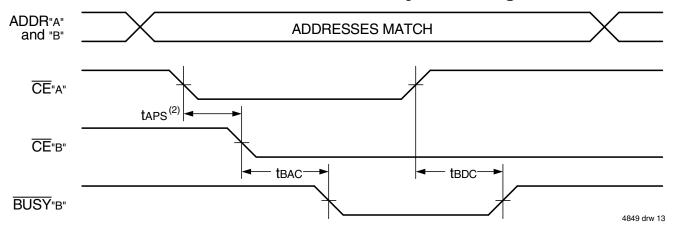
Timing Waveform of Write with $\overline{\text{BUSY}}$ (M/ $\overline{\text{S}}$ = VIL)



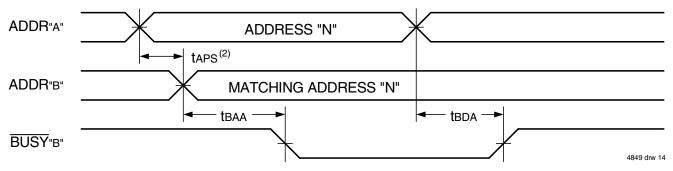
- 1. twH must be met for both BUSY input (SLAVE) and output (MASTER).
- 2. BUSY is asserted on port "B" blocking R/W"B", until BUSY"B" goes HIGH.
- 3. twb is only for the 'slave' version.

Industrial and Commercial Temperature Ranges

Waveform of **BUSY** Arbitration Controlled by \overline{CE} Timing (M/ \overline{S} = VIH)^(1,3)



Waveform of **BUSY** Arbitration Cycle Controlled by Address Match Timing $(M/S = VIH)^{(1)}$



NOTES:

1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

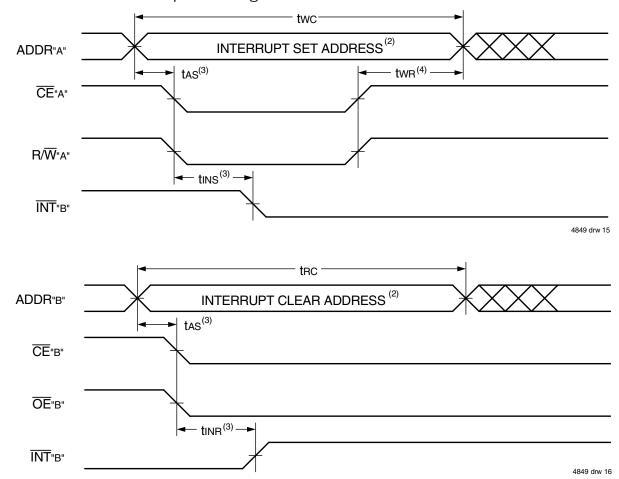
2. If tAPS is not satisfied, the BUSY signal will be asserted on one side or another but there is no guarantee on which side BUSY will be asserted.

3. Refer to Truth Table I - Chip Enable.

		70V28L15 Com'l Only		70V28L20 Com'l & Ind		
Symbol	Parameter	Min.	Max.	Min.	Мах.	Unit
INTERRUPT T	IMING					
tas	Address Set-up Time	0	_	0		ns
twr	Write Recovery Time	0	_	0		ns
tins	Interrupt Set Time		15		20	ns
tinr	Interrupt Reset Time		15		20	ns

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range

Waveform of Interrupt Timing^(1,5)



NOTES:

1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

2. Refer to Interrupt Truth Table.

- Timing depends on which enable signal (\overline{CE} or R/\overline{W}) is asserted last. 3.
- Timing depends on which enable signal $(\overline{CE} \text{ or } R/\overline{W})$ is de-asserted first. 4.

5. Refer to Truth Table I - Chip Enable.

	Left Port				Right Port					
R/₩L	CEL		A15L-A0L	ĪNTL	R/WR	CER	OE R	A15R-A0R	ĪNTR	Function
L	L	Х	FFFF	Х	Х	Х	Х	Х	L ⁽²⁾	Set Right INTR Flag
Х	Х	Х	Х	Х	Х	L	L	FFFF	H ⁽³⁾	Reset Right INTR Flag
Х	Х	Х	Х	L ⁽³⁾	L	L	Х	FFFE	Х	Set Left INTL Flag
Х	L	L	FFFE	H ⁽²⁾	Х	Х	Х	Х	Х	Reset Left INTL Flag

Truth Table IV — Interrupt Flag^(1,4,5)

NOTES:

1. Assumes $\overline{BUSY}_{L} = \overline{BUSY}_{R} = VIH$.

2. If $\overline{\text{BUSY}}L = VIL$, then no change.

3.

If $\overline{\text{BUSY}}_{R} = V_{IL}$, then no change. INTL and INTR must be initialized at power-up. 4.

Refer to Truth Table I - Chip Enable. 5.

Truth Table V — Address **BUSY** Arbitration⁽⁴⁾

	In	puts	Out		
ĒĒ∟	CE R	Aol-A15l Aor-A15r	BUS YL ⁽¹⁾	BUS YR ⁽¹⁾	Function
Х	Х	NO MATCH	Н	Н	Normal
Н	Х	MATCH	Н	Н	Normal
Х	Н	MATCH	Н	Н	Normal
L	L	MATCH	(2)	(2)	Write Inhibit ⁽³⁾

NOTES:

4849 tbl 17

 Pins BUSYL and BUSYR are both outputs when the part is configured as a master. Both are inputs when configured as a slave. BUSY outputs on the IDT70V28 are pushpull, not open drain outputs. On slaves the BUSY input internally inhibits writes.

 "L" if the inputs to the opposite port were stable prior to the address and enable inputs of this port. "H" if the inputs to the opposite port became stable after the address and enable inputs of this port. If tAPS is not met, either BUSYL or BUSYR = LOW will result. BUSYL and BUSYR outputs can not be LOW simultaneously.

3. Writes to the left port are internally ignored when BUSYL outputs are driving LOW regardless of actual logic level on the pin. Writes to the right port are internally ignored when BUSYR outputs are driving LOW regardless of actual logic level on the pin.

4. Refer to Truth Table I - Chip Enable.

Truth Table VI — Example of Semaphore Procurement Sequence^(1,2,3)

Functions	Do - D15 Left	Do - D15 Right	Status
No Action	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Left port has semaphore token
Right Port Writes "0" to Semaphore	0	1	No change. Right side has no write access to semaphore
Left Port Writes "1" to Semaphore	1	0	Right port obtains semaphore token
Left Port Writes "0" to Semaphore	1	0	No change. Left port has no write access to semaphore
Right Port Writes "1" to Semaphore	0	1	Left port obtains semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free
Right Port Writes "0" to Semaphore	1	0	Right port has semaphore token
Right Port Writes "1" to Semaphore	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Left port has semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free

NOTES:

1. This table denotes a sequence of events for only one of the eight semaphores on the IDT70V28.

2. There are eight semaphore flags written to via I/Oo and read from all I/O's (I/Oo-I/O15). These eight semaphores are addressed by Ao - A2.

3. $\overline{CE} = V_{IH}$, $\overline{SEM} = V_{IL}$ to access the semaphores. Refer to Truth Table III - Semaphore Read/Write Control.

Functional Description

The IDT70V28 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT70V28 has an automatic power down feature controlled by \overline{CE} . The $\overline{CE}o$ and CE1 control the on-chip power down circuitry that permits the respective port to go into a standby mode when not selected ($\overline{CE} = HIGH$). When a port is enabled, access to the entire memory array is permitted.

Interrupts

If the user chooses the interrupt function, a memory location (mail box or message center) is assigned to each port. The left port interrupt flag ($\overline{INT}L$) is asserted when the right port writes to memory location

FFFE (HEX), where a write is defined as $\overline{CE}R = R/\overline{W}R = VIL$ per Truth Table IV. The left port clears the interrupt through access of address location FFFE when $\overline{CE}L = \overline{OE}L = VIL$, R/\overline{W} is a "don't care". Likewise, the right port interrupt flag ($\overline{INT}R$) is asserted when the left port writes to memory location FFFF (HEX) and to clear the interrupt flag ($\overline{INT}R$), the right port must read the memory location FFFF. The message (16 bits) at FFFE or FFFF is user-defined since it is an addressable SRAMlocation. If the interrupt function is not used, address locations FFFE and FFFF are not used as mail boxes, but as part of the random access memory. Refer to Truth Table IV for the interrupt operation.

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Busy Logic

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "Busy". The BUSY pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a BUSY indication, the write signal is gated internally to prevent the write from proceeding.

The use of $\overline{\text{BUSY}}$ logic is not required or desirable for all applications. In some cases it may be useful to logically OR the $\overline{\text{BUSY}}$ outputs together and use any $\overline{\text{BUSY}}$ indication as an interrupt source to flag the event of an illegal or illogical operation. If the write inhibit function of $\overline{\text{BUSY}}$ logic is not desirable, the $\overline{\text{BUSY}}$ logic can be disabled by placing the part in slave mode with the M/S pin. Once in slave mode the $\overline{\text{BUSY}}$ pin operates solely as a write inhibit input pin. Normal operation can be programmed by tying the $\overline{\text{BUSY}}$ pins HIGH. If desired, unintended write operations can be prevented to a port by tying the $\overline{\text{BUSY}}$ pin for that port LOW.

The BUSY outputs on the IDT70V28 RAM in master mode, are push-pull type outputs and do not require pull up resistors to operate. If these RAMs are being expanded in depth, then the BUSY indication for the resulting array requires the use of an external AND gate.

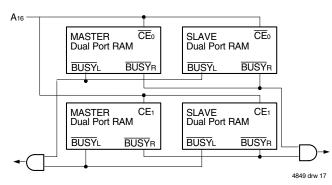


Figure 3. Busy and chip enable routing for both width and depth expansion with IDT70V28 RAMs.

Width Expansion with Busy Logic Master/Slave Arrays

When expanding an IDT70V28 RAM array in width while using $\overline{\text{BUSY}}$ logic, one master part is used to decide which side of the RAMs array will receive a $\overline{\text{BUSY}}$ indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master use the $\overline{\text{BUSY}}$ signal as a write inhibit signal. Thus on the IDT70V28 RAM the $\overline{\text{BUSY}}$ pin is an output if the part is used as a master (M/S pin = VIH), and the $\overline{\text{BUSY}}$ pin is an input if the part used as a slave (M/S pin = VIL) as shown in Figure 3.

If two or more master parts were used when expanding in width, a split decision could result with one master indicating $\overline{\text{BUSY}}$ on one side of the array and another master indicating $\overline{\text{BUSY}}$ on one other side of the array. This would inhibit the write operations from one port for part of a word and inhibit the write operations from the other port for the other part of the word.

The BUSY arbitration on a master is based on the chip enable and

address signals only. It ignores whether an access is a read or write. In a master/slave array, both address and chip enable must be valid long enough for a $\overline{\text{BUSY}}$ flag to be output from the master before the actual write pulse can be initiated with the R/W signal. Failure to observe this timing can result in a glitched internal write inhibit signal and corrupted data in the slave.

Semaphores

The IDT70V28 is an extremely fast Dual-Port 64K x 16 CMOS Static RAM with an additional 8 address locations dedicated to binary semaphore flags. These flags allow either processor on the left or right side of the Dual-Port RAM to claim a privilege over the other processor for functions defined by the system designer's software. As an example, the semaphore can be used by one processor to inhibit the other from accessing a portion of the Dual-Port RAM or any other shared resource.

The Dual-Port RAM features a fast access time, with both ports being completely independent of each other. This means that the activity on the left port in no way slows the access time of the right port. Both ports are identical in function to standard CMOS Static RAM and can be read from or written to at the same time with the only possible conflict arising from the simultaneous writing of, or a simultaneous READ/WRITE of, a non-semaphore location. Semaphores are protected against such ambiguous situations and may be used by the system program to avoid any conflicts in the non-semaphore portion of the Dual-Port RAM. These devices have an automatic power-down feature controlled by \overline{CE} , the Dual-Port RAM enable, and \overline{SEM} , the semaphore enable. The \overline{CE} and \overline{SEM} pins control on-chip power down circuitry that permits the respective port to go into standby mode when not selected. This is the condition which is shown in Truth Table III where \overline{CE} and \overline{SEM} are both HIGH.

Systems which can best use the IDT70V28 contain multiple processors or controllers and are typically very high-speed systems which are software controlled or software intensive. These systems can benefit from a performance increase offered by the IDT70V28s hardware semaphores, which provide a lockout mechanism without requiring complex programming.

Software handshaking between processors offers the maximum in system flexibility by permitting shared resources to be allocated in varying configurations. The IDT70V28 does not use its semaphore flags to control any resources through hardware, thus allowing the system designer total flexibility in system architecture.

An advantage of using semaphores rather than the more common methods of hardware arbitration is that wait states are never incurred in either processor. This can prove to be a major advantage in very high-speed systems.

How the Semaphore Flags Work

The semaphore logic is a set of eight latches which are independent of the Dual-Port RAM. These latches can be used to pass a flag, or token, from one port to the other to indicate that a shared resource is in use. The semaphores provide a hardware assist for a use assignment method called "Token Passing Allocation." In this method, the state of a semaphore latch is used as a token indicating that a shared resource is in use. If the left processor wants to use this resource, it requests the token by setting the latch. This processor then

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verifies its success in setting the latch by reading it. If it was successful, it proceeds to assume control over the shared resource. If it was not successful in setting the latch, it determines that the right side processor has set the latch first, has the token and is using the shared resource. The left processor can then either repeatedly request that semaphore's status or remove its request for that semaphore to perform another task and occasionally attempt again to gain control of the token via the set and test sequence. Once the right side has relinquished the token, the left side should succeed in gaining control.

The semaphore flags are active LOW. A token is requested by writing a zero into a semaphore latch and is released when the same side writes a one to that latch.

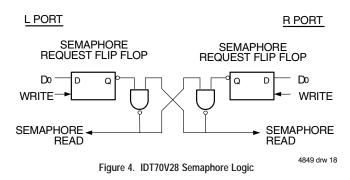
The eight semaphore flags reside within the IDT70V28 in a separate memory space from the Dual-Port RAM. This address space is accessed by placing a low input on the SEM pin (which acts as a chip select for the semaphore flags) and using the other control pins (Address, \overline{CE} , and R/\overline{W}) as they would be used in accessing a standard Static RAM. Each of the flags has a unique address which can be accessed by either side through address pins Ao – A2. When accessing the semaphores, none of the other address pins has any effect.

When writing to a semaphore, only data pin Do is used. If a low level is written into an unused semaphore location, that flag will be set to a zero on that side and a one on the other side (see Truth Table VI). That semaphore can now only be modified by the side showing the zero. When a one is written into the same location from the same side, the flag will be set to a one for both sides (unless a semaphore request from the other side is pending) and then can be written to by both sides. The fact that the side which is able to write a zero into a semaphore subsequently locks out writes from the other side is what makes semaphore flags useful in interprocessor communications. (A thorough discussion on the use of this feature follows shortly.) A zero written into the same location from the other side will be stored in the semaphore request latch for that side until the semaphore is freed by the first side.

When a semaphore flag is read, its value is spread into all data bits so that a flag that is a one reads as a one in all data bits and a flag containing a zero reads as all zeros. The read value is latched into one side's output register when that side's semaphore select (SEM) and output enable (\overline{OE}) signals go active. This serves to disallow the semaphore from changing state in the middle of a read cycle due to a write cycle from the other side. Because of this latch, a repeated read of a semaphore in a test loop must cause either signal (SEM or \overline{OE}) to go inactive or the output will never change.

A sequence WRITE/READ must be used by the semaphore in order to guarantee that no system level contention will occur. A processor requests access to shared resources by attempting to write a zero into a semaphore location. If the semaphore is already in use, the semaphore request latch will contain a zero, yet the semaphore flag will appear as one, a fact which the processor will verify by the subsequent read (see Table VI). As an example, assume a processor writes a zero to the left port at a free semaphore location. On a subsequent read, the processor will verify that it has written successfully to that location and will assume control over the resource in question. Meanwhile, if a processor on the right side attempts to write a zero to the same semaphore flag it will fail, as will be verified by the fact that a one will be read from that semaphore on the right side during subsequent read. Had a sequence of READ/WRITE been used instead, system contention problems could have occurred during the gap between the read and write cycles.

It is important to note that a failed semaphore request must be followed by either repeated reads or by writing a one into the same location. The reason for this is easily understood by looking at the simple logic diagram of the semaphore flag in Figure 4. Two semaphore request latches feed into a semaphore flag. Whichever latch is first to present a zero to the semaphore flag will force its side of the semaphore flag LOW and the other side HIGH. This condition will continue until a one is written to the same semaphore request latch. Should the other side's semaphore request latch have been written to

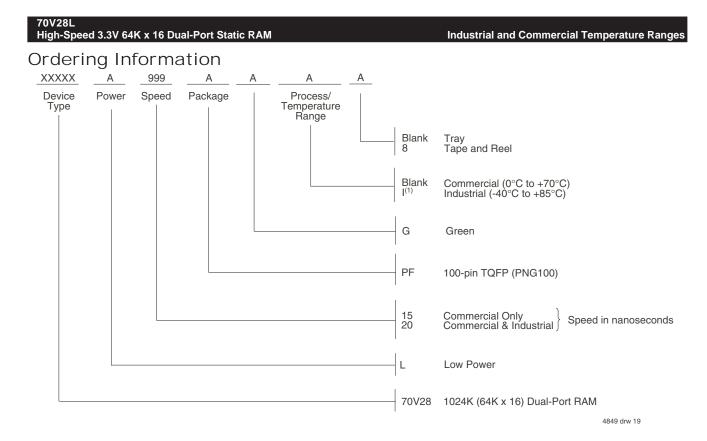


a zero in the meantime, the semaphore flag will flip over to the other side as soon as a one is written into the first side's request latch. The second side's flag will now stay LOW until its semaphore request latch is written to a one. From this it is easy to understand that, if a semaphore is requested and the processor which requested it no longer needs the resource, the entire system can hang up until a one is written into that semaphore request latch.

The critical case of semaphore timing is when both sides request a single token by attempting to write a zero into it at the same time. The semaphore logic is specially designed to resolve this problem. If simultaneous requests are made, the logic guarantees that only one side receives the token. If one side is earlier than the other in making the request, the first side to make the request will receive the token. If both requests arrive at the same time, the assignment will be arbitrarily made to one port or the other.

One caution that should be noted when using semaphores is that semaphores alone do not guarantee that access to a resource is secure. As with any powerful programming technique, if semaphores are misused or misinterpreted, a software error can easily happen.

Initialization of the semaphores is not automatic and must be handled via the initialization program at power-up. Since any semaphore request flag which contains a zero must be reset to a one, all semaphores on both sides should have a one written into them at initialization from both sides to assure that they will be free when needed.



NOTES:

- 1. Contact your sales office for Industrial Temperature range in other speeds, packages and powers.
- 2. LEAD FINISH (SnPb) are Obsolete Product Discontinuation Notice PDN#SP-17-02
- Note that information regarding recently obsoleted parts is included in this datasheet for customer convenience.

Orderable Part Information

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
15	70V28L15PFG	PNG100	TQFP	С
	70V28L15PFG8	PNG100	TQFP	С
20	70V28L20PFG	PNG100	TQFP	С
	70V28L20PFG8	PNG100	TQFP	С
	70V28L20PFGI	PNG100	TQFP	I
	70V28L20PFGI8	PNG100	TQFP	I

Datasheet Document History

08/01/99:		Initial Public Offering				
01/10/01:	Page 3	Increased storage temperature parameter				
	Ū	Clarified TA Parameter				
	Page 5	DC Electrical parameters-changed wording from "open" to "disabled"				
		Added Truth Table I - Chip Enable as note 5				
	Page 7	Corrected ±200mV to 0mV in notes				
	Page 5, 7, 10 8	& 12 Added Industrial Temperature information				
	Page 14	Added IV to Truth Table info in "Interrupts" paragraph				
	Page 17	Removed Preliminary status				
01/02/02:	Page 1 & 17	Replaced IDT logo				
	Pages 5, 7, 10	& 12 Removed Industrial Temperature range for 15ns from DC & AC Electrical Characteristics				
01/20/06:	Page 1	Added green availability to features				
		Added green indicator to ordering information				
10/23/08:	Page 17	Removed "IDT" from orderable part number				
04/08/15:	Page 2 Removed IDT in reference to fabrication					
	Page 2 &17 The package code PN100-1 changed to PN100 to match standard package codes					
	Page 17	Added Tape and Reel to Ordering Information				
	Pages 4-6, 8 8	Pages 4-6, 8 & 12-14 Corrected the text formatting for footnote that reads "Refer to Truth Table I - Chip Enable				
12/14/17:	Product Discontinuation Notice - PDN# SP-17-02					
	Last time buy expires June 15, 2018					
06/26/19:	Page 2 Rotated PNG100 TQFP pin configuration to accurately reflect pin 1 orientation					
	Page 17 Added Orderable Part Information table					



CORPORATE HEADQUARTERS 6024 Silver Creek Valley Road San Jose, CA 95138

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